PXIe-6570



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PXIe-6570 Specifications

These specifications apply to the PXIe-6570. When using the PXIe-6570 in the Semiconductor Test System, refer to the **Semiconductor Test System** Specifications.

Definitions

Warranted specifications describe the performance of a model under stated operating conditions and are covered by the model warranty. Warranted specifications account for measurement uncertainties, temperature drift, and aging. Warranted specifications are ensured by design or verified during production and calibration.

The following characteristic specifications describe values that are relevant to the use of the model under stated operating conditions but are not covered by the model warranty.

- *Typical* specifications describe the performance met by a majority of models.
- **Nominal** specifications describe an attribute that is based on design, conformance testing, or supplemental testing.

Conditions

Specifications are valid under the following conditions unless otherwise noted.

- Operating temperature of 0 °C to 45 °C
- Operating temperature within ±5 °C of the last self-calibration temperature
- Recommended calibration interval of 1 year. The PXIe-6570 will not meet specifications unless operated within the recommended calibration interval.
- DUT Ground Sense (DGS) same potential as the Ground (GND) pins



Note The DGS feature is only available on PXIe-6570 module revisions 158234C-xxL or later.

- Chassis fans set to the highest setting if the PXI Express chassis has multiple fan speed settings
- 30-minute warmup time before operation



Note When the pin electronics on the PXIe-6570 are in the disconnect state, some I/O protection and sensing circuitry remain connected. Do not subject the PXIe-6570 to voltages beyond the supported measurement range.

General

Channel count		32	
Multi-site resources per instrument		1	
NI-Digital 16.0			4
NI-Digital 17.0 and later			8
System channel count ^[1]	256		
Large Vector Memory (LVM)	128M vectors		
History RAM (HRAM)			
NI-Digital 17.5 and earlier 1,023 cycles			
NI-Digital 18.0 and later	5		
Maximum allowable offset (DGS minus GND)		±300 mV	

Supported measurement range ^[2]	-2 V to 7 V ^[3]
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Timing

Vector Timing

Maximum vector rate		100 MHz	
Vector period range		10 ns to 40 μs (100 MHz to 25 kHz)	
Vector period resolution		38 fs	
Timing control	Timing control		
Vector period	Vector-by-vector on the fly		
Edge timing	Per channel, vector-by-vector on the fly		
Drive formats	Per channel, vector-by-vector on the fly		

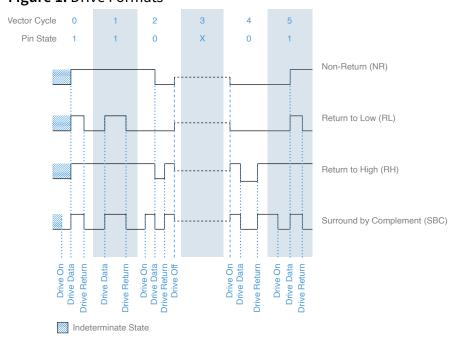
Clocking

Master clock source	PXIe_CLK100 ^[4]
Sequencer clock domains	One (independent sequencer clock domains on a single instrument not supported)

Drive and Compare Formats

Drive formats ^[5]				
100 MHz maximum vector rate	Non-Return (NR), Return to Low (RL), Return to High (RH)			
50 MHz maximum vector rate	Surround by Complem	ent (SBC) ^[6]		
Compare formats		Edge strobe		
Edge Multipliers ^[5]				
NI-Digital 17.5 and earlier			1x	
NI-Digital 18.0 and later			1x, 2x	

Figure 1. Drive Formats



Vector Cycle Pin State Non-Return (NR) Return to High (RH)

Figure 2. 2x Mode Drive Formats

Pin Data States

Indeterminate State

Pin States

- 0 Drive zero.
- 1 Drive one.
- L Compare low.
- H Compare high.
- X Do not drive; mask compare.
- M Compare midband, not high or low.
- V Compare high or low, not midband; store results from capture functionality if configured.
- D Drive data from source functionality if configured.
- E Expect data from source functionality if configured. [7]
- - Repeat previous cycle. Do not use a dash (-) for the pin state on the first vector of a pattern file unless the file is used only as a target of a jump or call operation.



Note Termination mode settings affect the termination applied to all nondriving pin states. Non-drive states include L, H, M, V, X, E, and potentially -. Refer to the Programmable input termination mode specification for more information.

Edge Timing

Edge Types

Drive edges			
NI-Digital 17.5 and earlier	4; drive on, driv	re data, drive return	
NI-Digital 18.0 and later	6; drive on, drive data, drive return, drive data 2, drive return 2, drive off		
Compare edges			
NI-Digital 17.5 and earlier		1; strobe	
NI-Digital 18.0 and later		2; strobe, strobe 2	
Number of time sets ^[8]			31

Edge Generation Timing

Edge placement range		
Minimum	Start of vector period (0 ns)	
Maximum	5 vector periods or 40 μs, whichever is smaller	
Minimum required edge separation		
Between any driven data change		
NI-Digital 17.5 and earlier 5 ns		

NI-Digital 18.0 and later 3.75 ns			3.75 ns		
Between any Drive On and Drive Off	Between any Drive On and Drive Off edges 5 ns				
Between Compare Strobes				5 ns	
Edge placement resolution			39.0625 ps		
Edge placement accuracy: Drive [9]					
NI-Digital 17.5 and earlier					
Edge Multiplier = 1x		±500 ps, warranted			
NI-Digital 18.0 and later					
Edge Multiplier = 1x ±500 ps, warranted					
Edge Multiplier = 2x	Bit rate ≤ 200 Mbps: ±500 ps, typical				
Edge Multiplier = 2x	Bit rate ≤ 266 Mbps: ±600 ps, typical				
Edge placement accuracy: Compare [9]					
NI-Digital 17.5 and earlier					
Edge Multiplier = 1x ±500 ps, warranted					
NI-Digital 18.0 and later					
Edge Multiplier = 1x	ge Multiplier = 1x ±500 ps, warranted				

Edge Multiplier = 2x	Bit rate ≤ 100 Mbps: ±500 ps, typical		
Edge Multiplier = 2x	Bit rate ≤ 133 Mbps: ±700 ps, typical		
Overall timing accuracy [9]			
NI-Digital 17.5 and earlier			
Edge Multiplier = 1x		±1.5 ns, warranted	
NI-Digital 18.0 and later			
Edge Multiplier = 1x	lier = 1x ±1.5 ns, warra		
Edge Multiplier = 2x	Bit rate ≤ 200 Mbps: ±1.5 ns, typical		
Edge Multiplier = 2x	Bit rate ≤ 266 Mbps: ±1.8 ns, typical		
TDR deskew adjustment resolution			39.0625 ps

Driver, Comparator, Load

Driver

Signal type	Single-ended, referenced to the DGS pin when connected. Otherwise referenced to GND.
Programmable levels	V _{IH} , V _{IL} , V _{TERM}
Voltage levels	

Range (V _{IH} , V _{IL} , V _{TERM})		-2 V to 6 V
Minimum swing (V _{IH} minus V _{IL})		400 mV, into a 1 MΩ load
Resolution (V _{IH} , V _{IL} , V _{TERM})		122 μV
Accuracy (V _{IH} , V _{IL} , V _{TERM})		±15 mV, 1 MΩ load, warranted
Maximum DC drive current	±32 mA	
Output impedance	50 Ω	
Rise/fall time, 20% to 80%	1.2 ns, up to 5 V	

Comparator

Signal type	Single-ended, referenced to the DGS pin when connected. Otherwise referenced to GND.	
Programmable levels	V _{OH} , V _{OL}	
Voltage levels		
Range (V _{OH} , V _{OL})	-2 V to 6 V	

Resolution (V _{OH} , V _{OL})	122 μV	
Accuracy (V _{OH} , V _{OL})	±25 mV, from -1.5 V to 5.8 V, warranted	
Programmable input termination modes	High Z, 50 Ω to V _{TERM} , Active Load	
Leakage current	<15 nA, in the High Z termination mode	

Active Load

Programmable levels			I _{OH} , I _{OL}
Commutating voltage (V	сом)		
Range		-2 V to 6 V	
Resolution		122 μV	
Current levels			
Range	1.5 mA to 24 mA		
Resolution	488 nA		
Accuracy	1 mA, 3 V over/under drive, typical		

PPMU

PPMU Force Voltage

Signal Single-ended, referenced to the DGS pin when connected. Otherwise referenced to type GND.				
Voltage leve	els			
Range				
NI-Digital 17.5 and earlier -2 V to 6		-2 V to 6 V		
NI-Digital 18.0 and later		-2 V to 6 V 6 V to 7 V in Extended Voltage Range ^[10]		
Resolution			122 μV	
Accuracy				
NI-Digital 17.5 and earlier ± 15 mV, 1 M Ω load, from -2 V to 6 V, warranted		n -2 V to 6 V, warranted		
NI-Digital 18	± 15 mV, 1 M Ω load, from -2 V to 6 V, warranted NI-Digital 18.0 and later ± 50 mV, 1 M Ω load, from 6 V to 7 V, typical $^{\left[10\right]}$			

PPMU Measure Voltage

Signal type	Single-ended, referenced to the DGS pin when connected. Otherwise referenced to GND.
Voltage levels	

Range	-2 V to 6 V
Resolution	228 μV
Accuracy	±5 mV, warranted

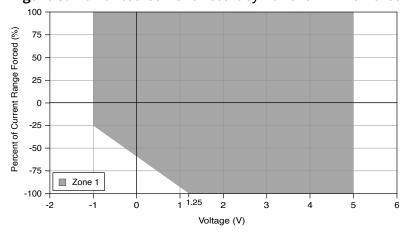
PPMU Force Current

How to Calculate PPMU Force Current Accuracy

Table 1. PPMU Force Current Accuracy

Range	Resolution	Accuracy
±2 μA	60 pA	
±32 μA	980 pA	
±128 μA	3.9 nA	±1% of range for Zone 1 of Figure 3, warranted
±2 mA	60 nA	<u> </u>
±32 mA	980 nA	

Figure 3. Warranted Current Accuracy Zone for PPMU Force Current





Note The boundaries of Zone 1 are inclusive of that zone. The area outside of Zone 1 does not have a warranted spec for PPMU force current accuracy.

- 1. Specify the desired forced current.
- 2. Based on the desired forced current, select an appropriate current range from Table 1.
- 3. Divide the desired forced current from step 1 by the current range from step 2 and multiply by 100 to calculate the Percent of Current Range Forced.
- 4. Based on the impedance of the load, calculate the voltage required to force the desired current from step 1. Use the following equation: Voltage Required = Desired Current * Load Impedance.
- 5. Using Figure 2, locate the zone in which the Percent of Current Range Forced calculated in step 3 intersects with the Voltage calculated in step 4. If the intersection is outside of Zone 1, then there are no warranted specs. To get warranted specs, the current range and/or forced current must be adjusted until the intersection is in Zone 1.
- 6. Based on the zone found in step 5, use Table 1 to calculate the accuracy of the forced current.

PPMU voltage clamps		
Range	-2 V to 6 V	
Resolution	122 μV	
Accuracy	±100 mV, typical	

PPMU Measure Current

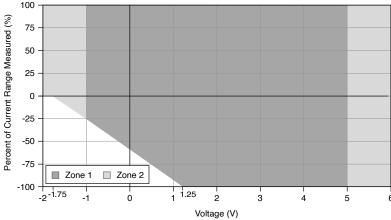
How to Calculate PPMU Measure Current Accuracy

Table 2. PPMU Measure Current Accuracy

Range	Resolution	Accuracy
±2 μA	460 pA	
±32 μA	7.3 nA	±1% of range for Zone 1 of Figure 4, warranted
±128 μA	30 nA	· · · · · · · · · · · · · · · · · · ·

Range	Resolution	Accuracy
±2 mA	460 nA	
±32 mA	7.3 μΑ	±1.5% of range for Zone 2 of Figure 4, warranted

Figure 4. Warranted Current Accuracy Zones for PPMU Measure Current





Note The boundaries of Zone 1 are inclusive of that zone. All other boundaries are inclusive of Zone 2. The area outside of Zone 1 and Zone 2 does not have a warranted spec for PPMU measure current accuracy.

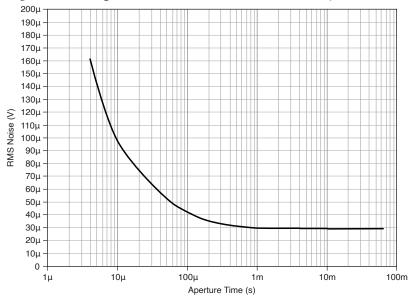
- 1. Specify the desired measured current.
- 2. Based on the desired measured current, select an appropriate current range from Table 2.
- 3. Divide the desired measured current from step 1 by the current range from step 2 and multiply by 100 to calculate the Percent of Current Range Measured.
- 4. If forcing voltage and then measuring current, Voltage in Figure 3 is equal to the forced voltage. If forcing current and then measuring current, Voltage in Figure 3 is equal to the voltage required to force the desired current based on the impedance of the load. Use the following equation: Voltage Required = Desired Current * Load Impedance.
- 5. Using Figure 3, locate the zone in which the Percent of Current Range Measured calculated in step 3 intersects with the Voltage calculated in step 4. If the intersection is outside of Zone 1 or Zone 2, then there are no warranted specs. To get warranted specs, the current range and forced current or forced voltage must be adjusted until the intersection is in Zone 1 or Zone 2.

6. Based on the zone found in step 5, use Table 2 to calculate the accuracy of the measured current.

PPMU Programmable Aperture Time

Aperture time		
Minimum	4 μs	
Maximum	65 ms	
Resolution	4 μs	

Figure 5. Voltage Measurement Noise for Given Aperture Times, Typical



Pattern Control

Opcodes

Refer to the following table for supported opcodes. Using matched and failed opcode parameters with multiple PXIe-6570 instruments requires the PXIe-6674T synchronization module. Other uses of flow-control opcodes with multiple PXIe-6570

instruments only require NI-TCLK synchronization.

Category	Supported Opcodes
Flow Control	 repeat jump jump_if set_loop end_loop exit_loop exit_loop_if call return keep_alive match halt
Sequencer Flags and Registers	set_seqflagclear_seqflagwrite_reg
Signal	set_signalpulse_signalclear_signal
Digital Source and Capture	capture_startcapturecapture_stopsource_startsourcesourced_replace



Note The source_d_replace opcode is only available with NI-Digital 18.0 or later.

Pipeline Latencies

Minimum delay between source_start opcode and the first source opcode or subsequent source_start opcode	3 μs
Matched and failed condition pipeline latency	80 cycles

Source and Capture

Digital Source ^[11]	Digital Source ^[11]	
Operation modes	Serial and parallel; broadcast and site-unique	
Source memory size	32 MB (256 Mbit) total	
Maximum waveforms	512	
Digital Capture ^[11]		
Operation modes		Serial and parallel; site-unique
Capture memory size		1 million samples
Maximum waveforms		512

Independent Clock Generators



Note This functionality requires NI-Digital 18.0 or later.

Number of Clock Generators	32 (one per pin)
Clock Period Range	6.25 ns to 40 us (160 MHz to 25 kHz) ^[12]
Clock Period Resolution	38 fs

Frequency Measurements



Note This functionality requires NI-Digital 17.0 or later.

Frequency counter measure frequency		
Range	5 kHz to 200 MHz, 2.5 ns minimum pulse width	
Accuracy	See <u>Calculating Frequency Counter Error</u>	

Calculating Frequency Counter Error

Use the following equation to calculate the frequency counter error (ppm).

$$\left| \frac{{\it TB}_{\it err}}{\left(1-{\it TB}_{\it err}\right)} + \frac{20ns}{\left(MeasurementTime-UnknownClockPeriod\right)} \right| * 1, 000, 000$$

where

- MeasurementTime is the time, in seconds, over which the frequency counter measurement is configured to run
- UnknownClockPeriod is the time, in seconds, of the period of the signal being measured
- TB_{err} is the error of the Clk100 timebase

Refer to the following table for a few examples of common Clk100 timebase accuracies.

Table 3. TBerr

PXI Express Hardware Specification Revision 1.0	PXIe-1085 Chassis	PXIe-6674T Override
100 μ (100 ppm)	25 μ (25 ppm)	80 n (80 ppb)

Example 1: Calculating Error with a PXIe-1085 Chassis

Calculate the error of performing a frequency measurement of a 10 MHz clock (100 ns period) with a 1 ms measurement time using the PXIe-Clk100 provided by the PXIe-1085 chassis as the timebase.

Solution

$$\left(\frac{25\mu}{(1-25\mu)} + \frac{20ns}{(1ms-100ns)}\right) * 1, 000, 000$$

=45ppm

Example 2: Calculating Error when Overriding with the PXIe-6674T

Calculate the error if you override the PXIe-Clk100 timebase with the PXIe-6674T and increase the measurement time to 10 ms.

Solution

$$\left(\frac{80n}{(1-80n)} + \frac{20ns}{(10ms-100ns)}\right) * 1, 000, 000$$

= 2*ppm*

Calibration Interval

talibration interval 1 year

Physical Characteristics

PXIe slots	2
Dimensions	131 mm × 42 mm × 214 mm (5.16 in. × 1.65 in. × 8.43 in.)
Weight	920 g (32.45 oz.)

Power Requirements

The PXIe-6570 draws current from a combination of the 3.3 V and 12 V power rails. The maximum current drawn from each of these rails can vary depending on the PXIe-6570 mode of operation. The total power consumption will not exceed the input power specification.

Input power		68 W
Current Draw		
3.3 V	4.4 A	
12 V	4.7 A	